## Applicant(s)/Patent Under Application/Control No. Reexamination 10/658,506 ZHENG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 ANH PHUNG 2824 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY \* US-6,754,105 06-2004 365/185.18 Chang et al. Α \* US-6,122,201 09-2000 Lee et al. 365/185.29 В С US-6,011,725 01-2000 Eitan, Boaz 365/185.33 US-5,768,192 06-1998 365/185.24 D Eitan, Boaz US-Ε US-F US-G US-Н US-١ J US-US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Classification Country Name MM-YYYY Country Code-Number-Kind Code Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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